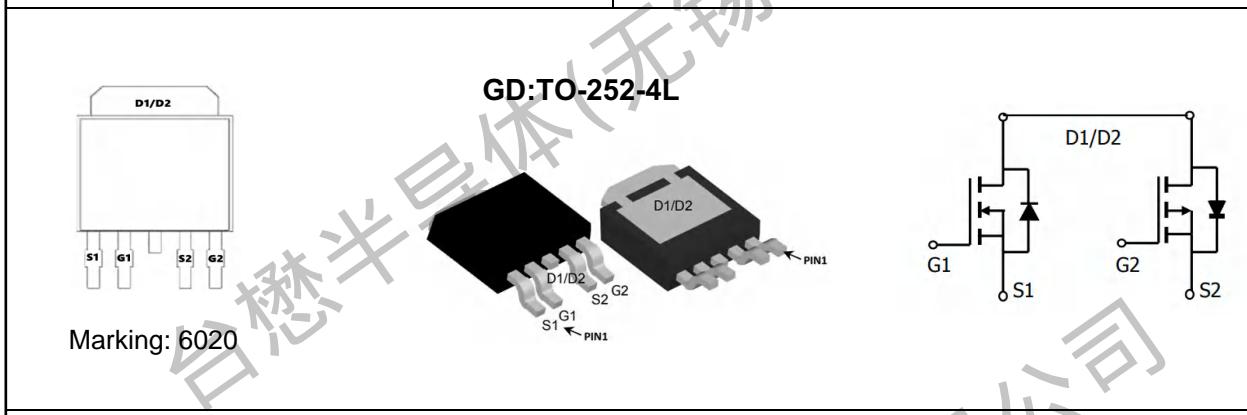


**TM20G06GD**
**N+P-Channel Enhancement Mode Mosfet**

<b>General Description</b> <ul style="list-style-type: none"> <li>Low <math>R_{DS(ON)}</math></li> <li>RoHS and Halogen-Free Compliant</li> </ul> <b>Applications</b> <ul style="list-style-type: none"> <li>Load switch</li> <li>PWM</li> </ul>	<b>General Features</b> <p><b>N Channel</b>  <math>V_{DS} = 60V</math> <math>I_D = 20A</math>  <math>R_{DS(ON)} = 30m\Omega</math> (typ.) @ <math>V_{GS} = 10V</math></p> <p><b>P Channel</b>  <math>V_{DS} = -60V</math> <math>I_D = -15A</math>  <math>R_{DS(ON)} = 70m\Omega</math> (typ.) @ <math>V_{GS} = -10V</math></p> <p>100% UIS Tested      100% <math>R_g</math> Tested</p>
--	---


**Absolute Maximum Ratings ( $T_c = 25^\circ C$  unless otherwise noted)**

Symbol	Parameter	Rating		Units
		N-Ch	P-Ch	
$V_{DS}$	Drain-Source Voltage	60	-60	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	$\pm 20$	V
$I_D @ T_a = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	20	-15	A
$I_D @ T_a = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	13	-9.8	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	74	-56	A
EAS	Single Pulse Avalanche Energy <sup>3</sup>	22	29.8	mJ
$P_D @ T_c = 25^\circ C$	Total Power Dissipation <sup>4</sup>	50	50	W
$I_{AS}$	Avalanche Current, Single pulse	21	-24.4	A
$T_{STG}$	Storage Temperature Range	-55 to 175	-55 to 175	°C
$T_J$	Operating Junction Temperature Range	-55 to 175	-55 to 175	°C

**Thermal Data**

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient <sup>1</sup>	---	60	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	3.8	°C/W

**TM20G06GD**
**N+P-Channel Enhancement Mode Mosfet**
**N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=250\mu\text{A}$	60	---	---	V
$\text{R}_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{\text{GS}}=10\text{V}$ , $I_D=15\text{A}$	---	30	40	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$ , $I_D=7\text{A}$	---	35	45	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D=250\mu\text{A}$	1.0	2.0	3.0	V
$\text{I}_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=48\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	1	$\text{uA}$
		$V_{\text{DS}}=48\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=55^\circ\text{C}$	---	---	5	
$\text{I}_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm 100$	nA
$\text{gfs}$	Forward Transconductance	$V_{\text{DS}}=5\text{V}$ , $I_D=15\text{A}$	---	25.3	---	S
$\text{Q}_g$	Total Gate Charge (10V)	$V_{\text{DS}}=48\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $I_D=15\text{A}$	---	19	---	$\text{nC}$
$\text{Q}_{\text{gs}}$	Gate-Source Charge		---	2.5	---	
$\text{Q}_{\text{gd}}$	Gate-Drain Charge		---	5	---	
$\text{T}_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=30\text{V}$ , $V_{\text{GS}}=10\text{V}$ , $R_{\text{G}}=3.3\Omega$	---	2.8	---	$\text{ns}$
$\text{T}_r$	Rise Time		---	16.6	---	
$\text{T}_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	21.2	---	
$\text{T}_f$	Fall Time		---	5.6	---	
$\text{C}_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=15\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	1027	---	$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance		---	65	---	
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		---	46	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{I}_s$	Continuous Source Current <sup>1,6</sup>	$V_G=V_D=0\text{V}$ , Force Current	---	---	20	A
$\text{V}_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$V_{\text{GS}}=0\text{V}$ , $\text{I}_s=1\text{A}$ , $T_J=25^\circ\text{C}$	---	---	1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{\text{DD}}=25\text{V}$ ,  $V_{\text{GS}}=10\text{V}$ ,  $L=0.1\text{mH}$ ,  $\text{I}_{\text{AS}}=21\text{A}$
- 4.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5.The data is theoretically the same as  $\text{I}_D$  and  $\text{I}_{\text{DM}}$  , in real applications , should be limited by total power dissipation.

# TM20G06GD

## N+P-Channel Enhancement Mode Mosfet

### P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_D=-250\mu\text{A}$	-60	---	---	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{\text{GS}}=-10\text{V}$ , $I_D=10\text{A}$	---	70	80	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$ , $I_D=5\text{A}$	---	85	100	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$ , $I_D=-250\mu\text{A}$	-1.0	-2.0	-3.0	V
$I_{\text{DSS}}$	Drain-Source Leakage Current	$V_{\text{DS}}=-48\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$	---	---	1	$\text{uA}$
		$V_{\text{DS}}=-48\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=55^\circ\text{C}$	---	---	5	
$I_{\text{GSS}}$	Gate-Source Leakage Current	$V_{\text{GS}}=\pm20\text{V}$ , $V_{\text{DS}}=0\text{V}$	---	---	$\pm100$	nA
$g_{\text{fs}}$	Forward Transconductance	$V_{\text{DS}}=-5\text{V}$ , $I_D=-4\text{A}$	---	8.7	---	S
$Q_g$	Total Gate Charge (-4.5V)	$V_{\text{DS}}=-12\text{V}$ , $V_{\text{GS}}=-4.5\text{V}$ , $I_D=-6\text{A}$	---	11.8	---	$\text{nC}$
$Q_{\text{gs}}$	Gate-Source Charge		---	1.9	---	
$Q_{\text{gd}}$	Gate-Drain Charge		---	6.5	---	
$T_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=-15\text{V}$ , $V_{\text{GS}}=-10\text{V}$ , $R_G=3.3\Omega$ , $I_D=-1\text{A}$	---	8.8	---	$\text{ns}$
$T_r$	Rise Time		---	19.6	---	
$T_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	47.2	---	
$T_f$	Fall Time		---	9.6	---	
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-15\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	1080	---	$\text{pF}$
$C_{\text{oss}}$	Output Capacitance		---	73	---	
$C_{\text{rss}}$	Reverse Transfer Capacitance		---	50	---	

### Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_s$	Continuous Source Current <sup>1,5</sup>	$V_G=V_D=0\text{V}$ , Force Current	---	---	-15	A
$V_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$V_{\text{GS}}=0\text{V}$ , $I_s=-1\text{A}$ , $T_J=25^\circ\text{C}$	---	---	-1	V

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu\text{s}$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{\text{DD}}=-25\text{V}$ , $V_{\text{GS}}=-10\text{V}$ , $L=0.1\text{mH}$ , $I_{\text{AS}}=-24.4\text{A}$
- 4.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5.The data is theoretically the same as  $I_D$  and  $I_{\text{DM}}$  , in real applications , should be limited by total power dissipation.

## TM20G06GD

## N+P-Channel Enhancement Mode Mosfet

### N-Channel Typical Characteristics

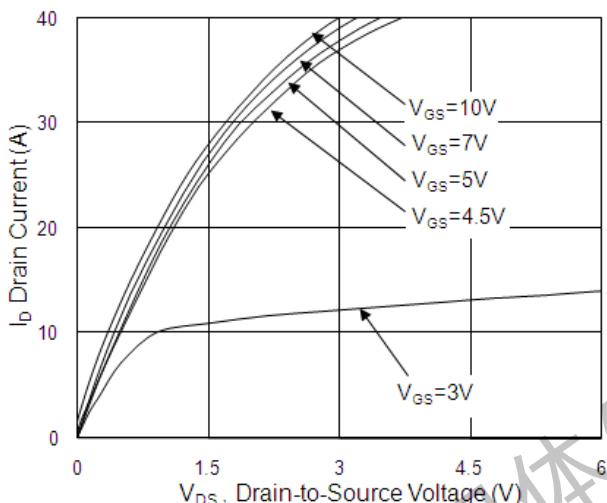


Fig.1 Typical Output Characteristics

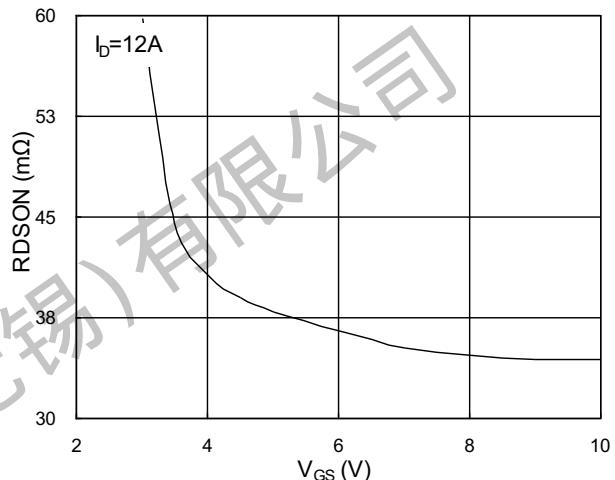


Fig.2 On-Resistance vs. G-S Voltage

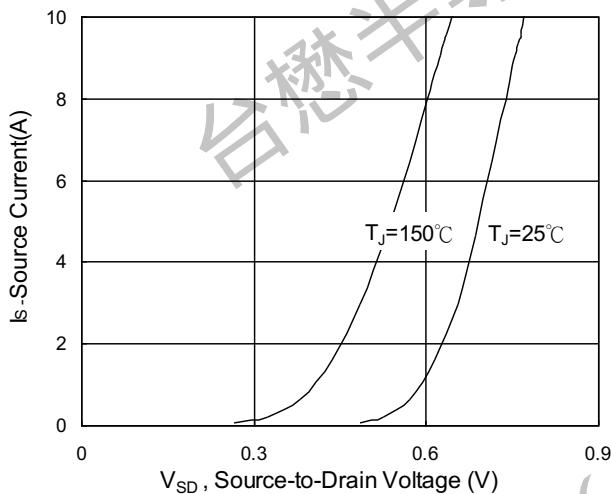


Fig.3 Source Drain Forward Characteristics

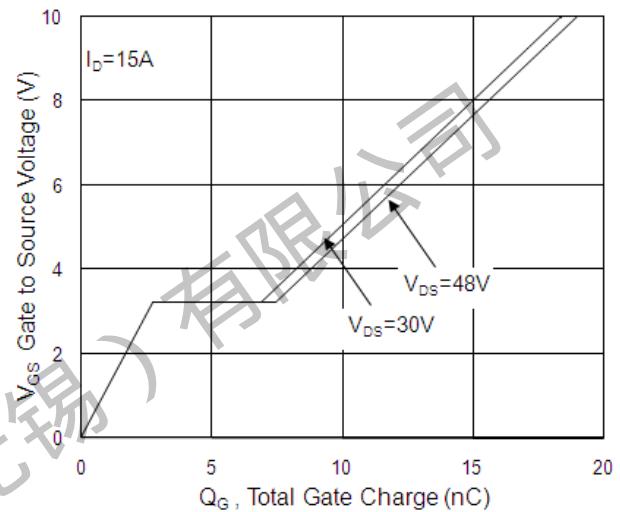


Fig.4 Gate-Charge Characteristics

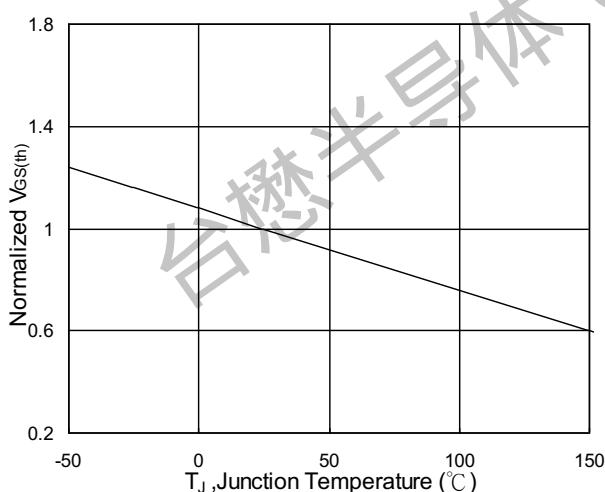


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

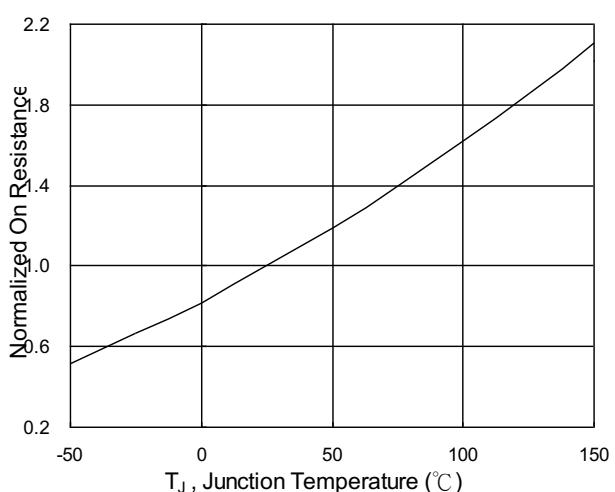
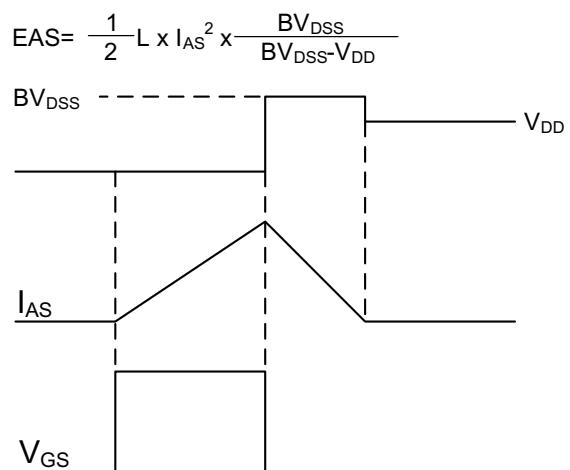
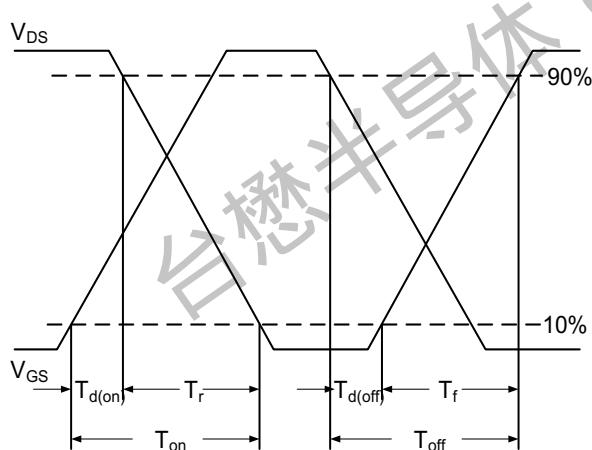
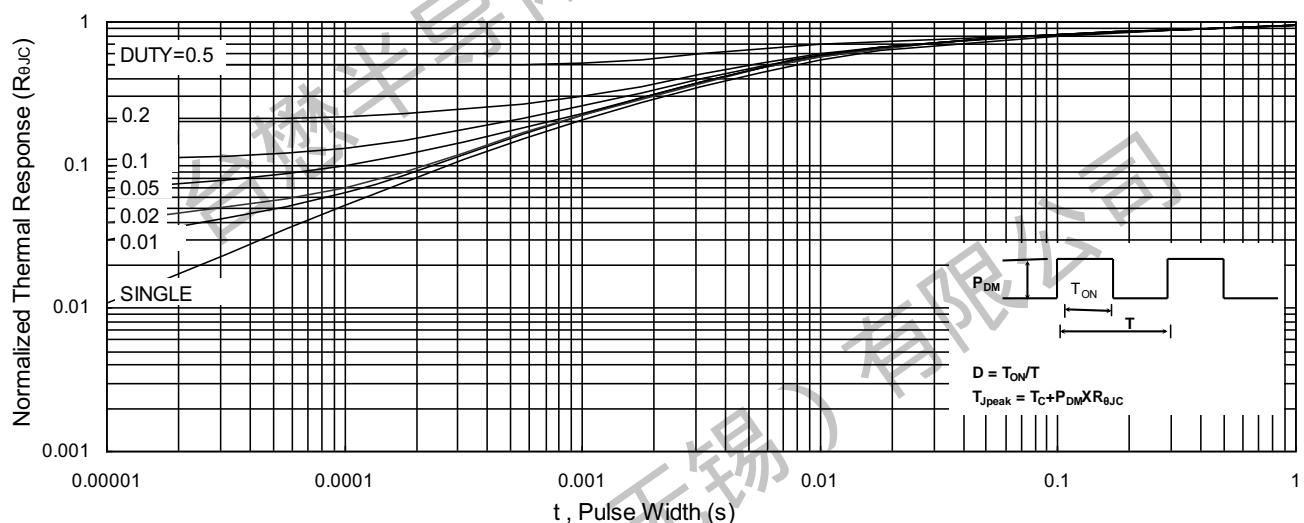
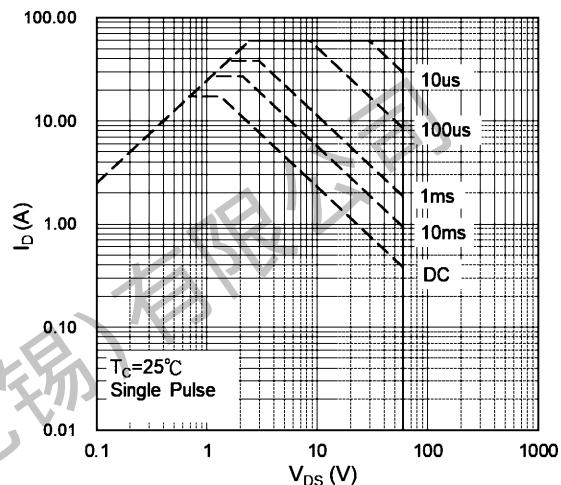
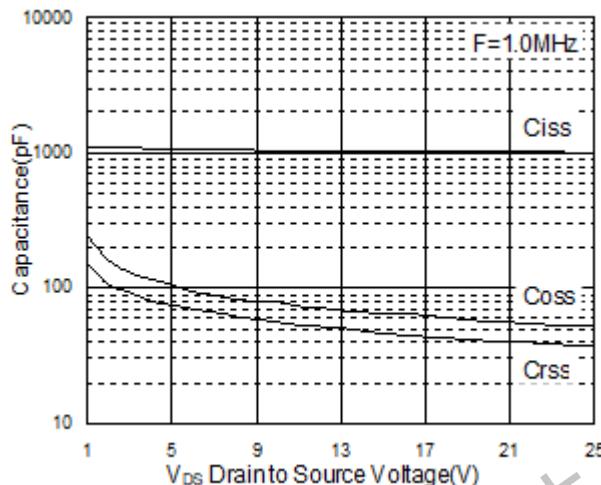


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>

## TM20G06GD

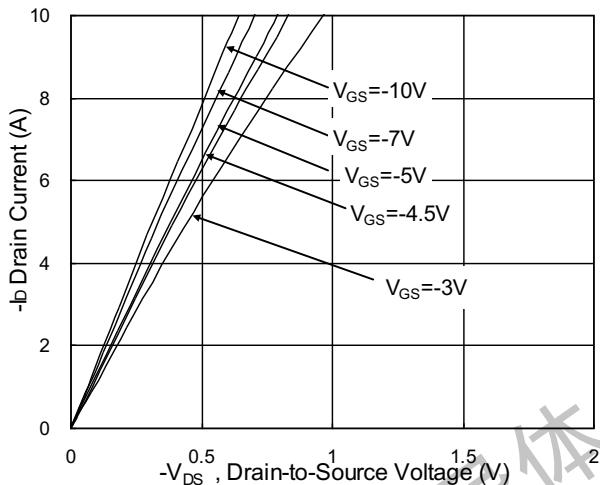
## N+P-Channel Enhancement Mode Mosfet



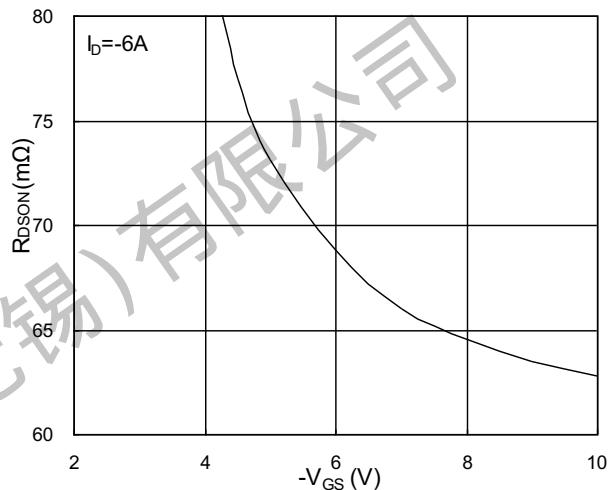
## TM20G06GD

## N+P-Channel Enhancement Mode Mosfet

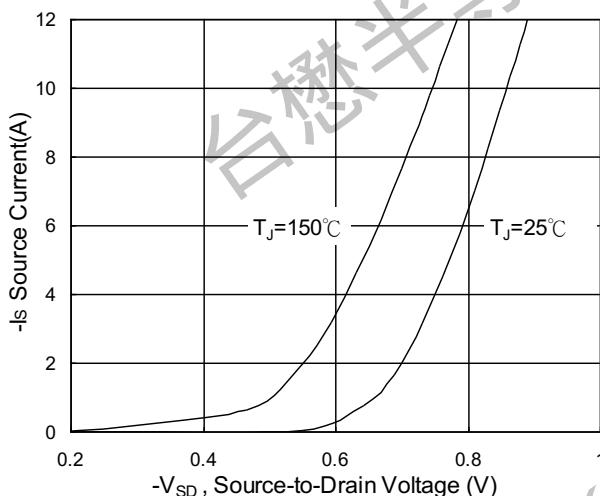
### P-Channel Typical Characteristics



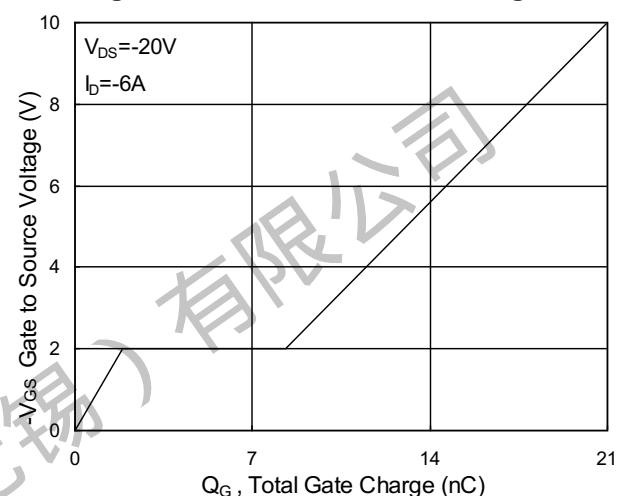
**Fig.1 Typical Output Characteristics**



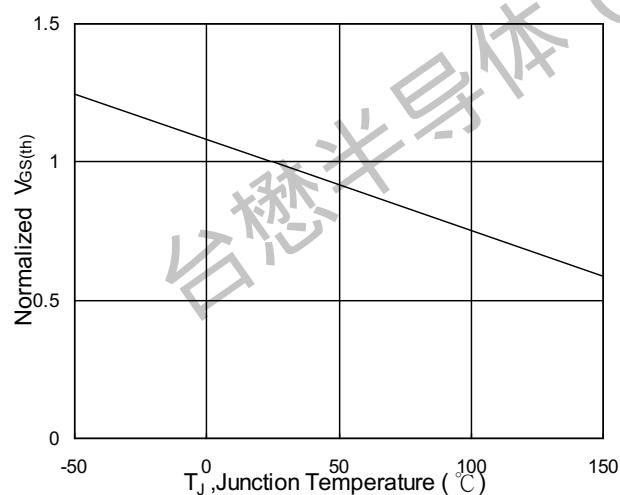
**Fig.2 On-Resistance vs. G-S Voltage**



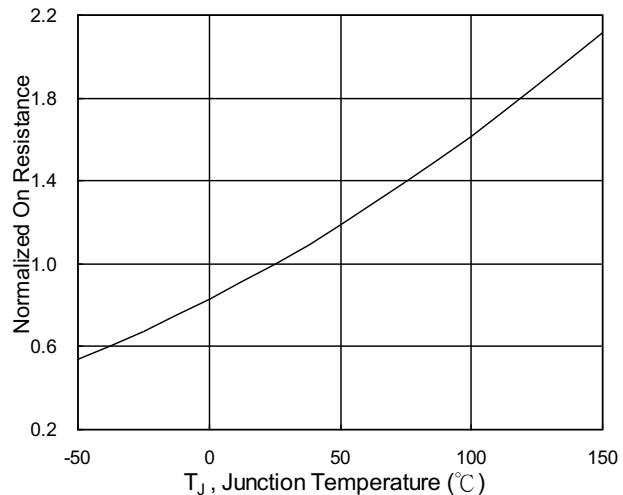
**Fig.3 Source Drain Forward Characteristics**



**Fig.4 Gate-Charge Characteristics**



**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

## TM20G06GD

## N+P-Channel Enhancement Mode Mosfet

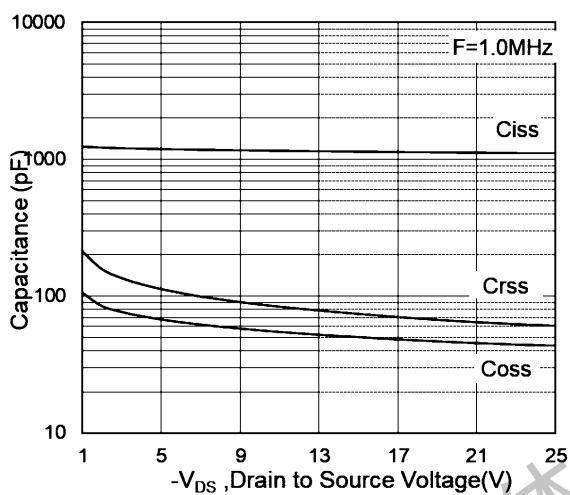


Fig.7 Capacitance

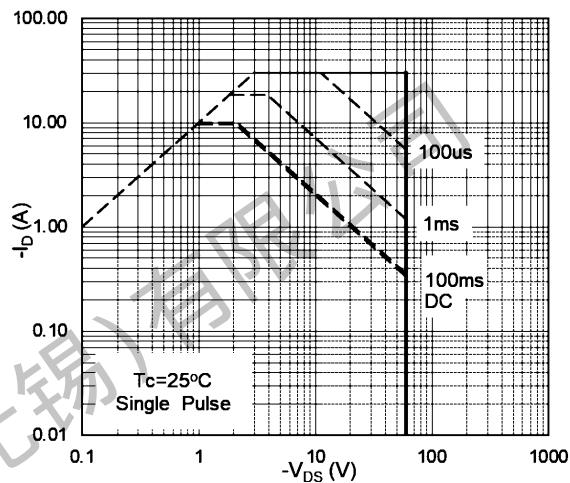


Fig.8 Safe Operating Area

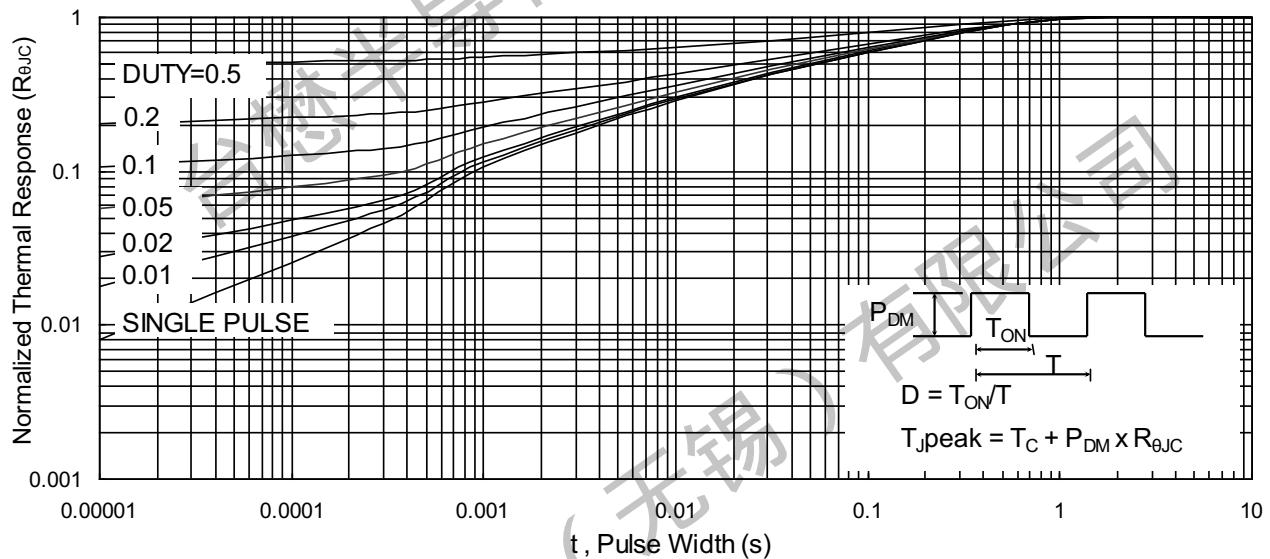


Fig.9 Normalized Maximum Transient Thermal Impedance

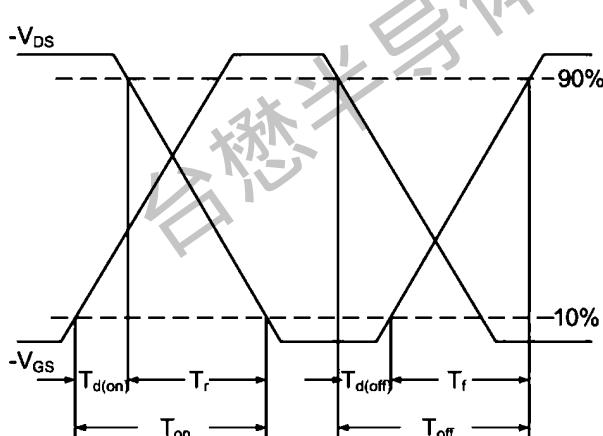


Fig.10 Switching Time Waveform

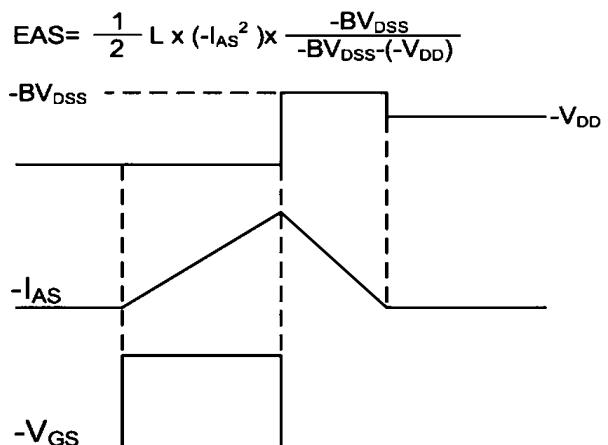
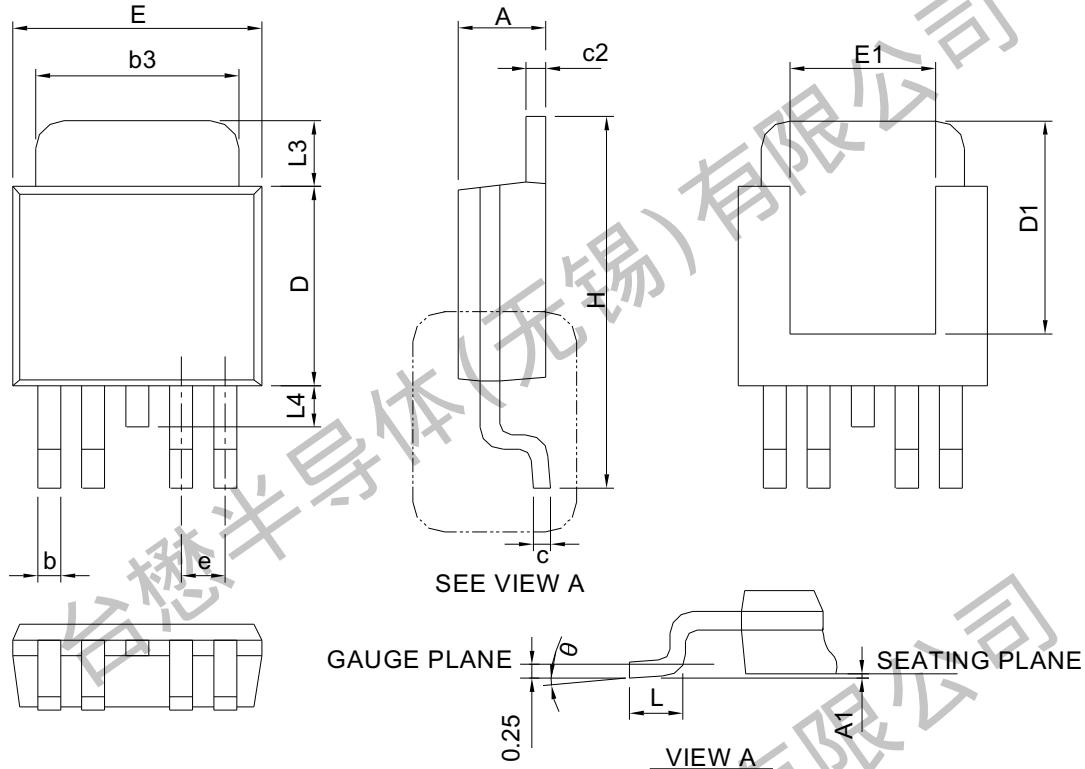


Fig.11 Unclamped Inductive Switching Waveform

## TM20G06GD

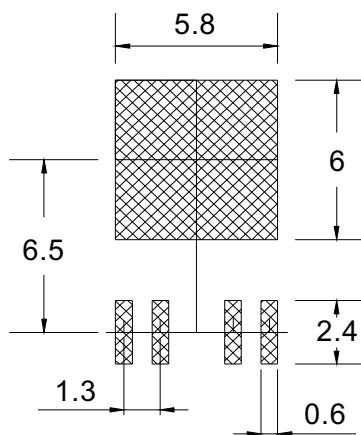
## N+P-Channel Enhancement Mode Mosfet

### Package Mechanical Data: TO-252-4L



SYMBOL	TO-252-4			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	0.086	0.094
A1	-	0.2	-	0.008
b	0.50	0.71	0.020	0.028
b3	4.32	5.46	0.170	0.215
c	0.46	0.61	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.33	6.22	0.210	0.245
D1	4.57	6.00	0.180	0.236
E	6.35	6.73	0.250	0.265
E1	3.81	6.00	0.150	0.236
e	1.30 BSC		0.051 BSC	
H	9.40	10.41	0.370	0.410
L	1.40	1.78	0.055	0.070
L3	0.89	2.03	0.035	0.080
L4	-	1.02	-	0.040
θ	0°	8°	0°	8°

### RECOMMENDED LAND PATTERN

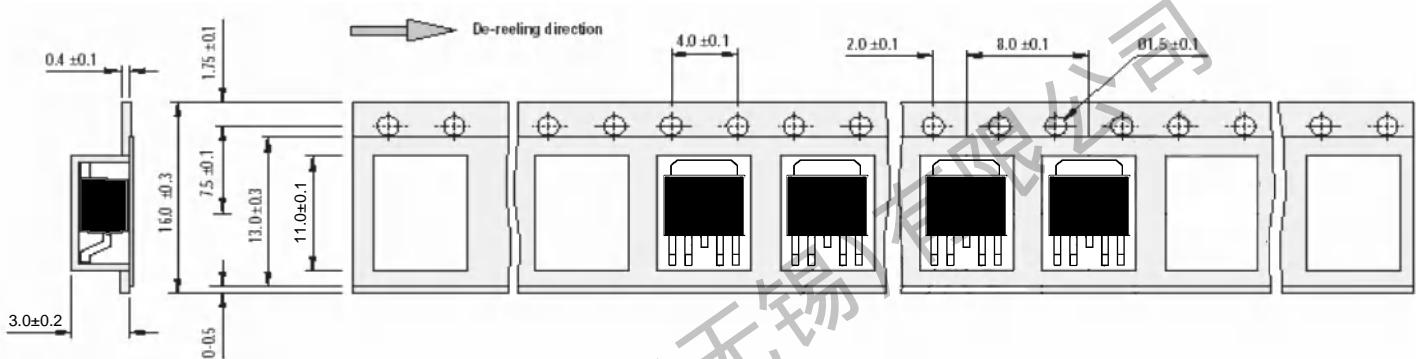


UNIT: mm

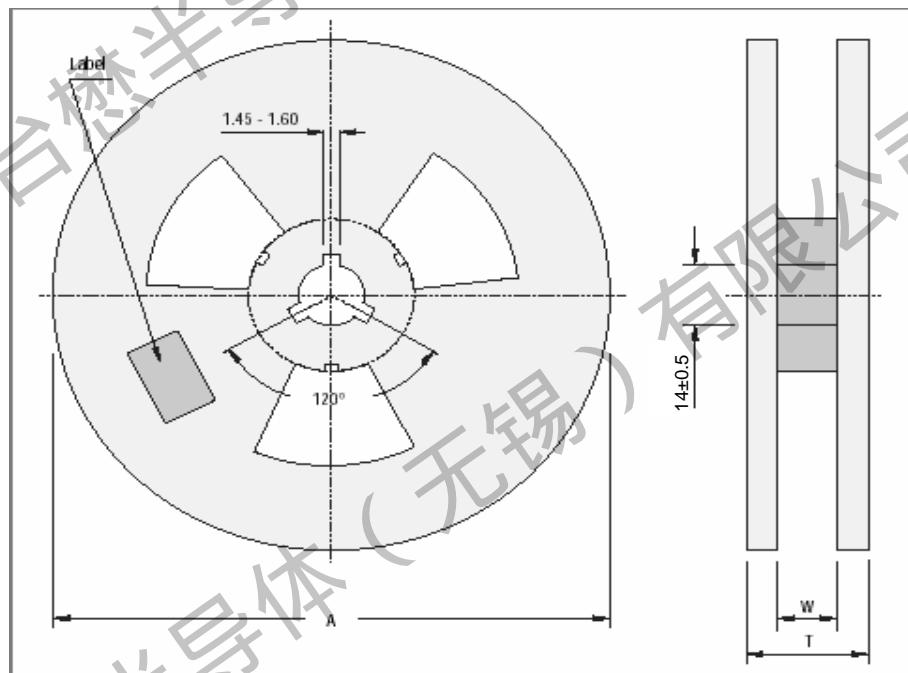
## TM20G06GD

N+P-Channel Enhancement Mode Mosfet

TO-252-4L Embossed Carrier Tape



TO-252-4L Reel



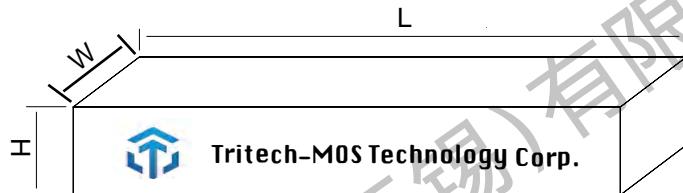
### 1.TO-252-4L Packaging

Package	Packing Form	Quantity		
		Reel	Inner Box	Outbox
TO-252-4L	Reel	2500	5	1

**TM20G06GD**

**N+P-Channel Enhancement Mode Mosfet**

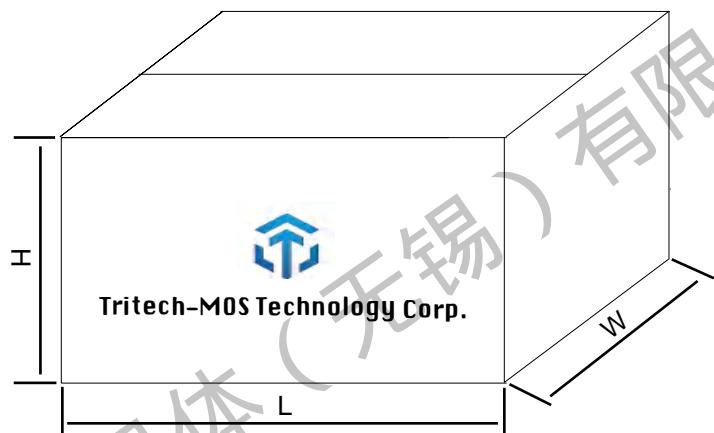
**Inner Box**



Dimension : 370 (L)×355(W) ×50(H) mm

Quantity : 2500 × 2Ea = 5000pcs

**Outer Box**



Dimension : 380(L)×380(W) ×275(H) mm

Quantity : 5000 × 5Ea = 25000pcs

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#### Revision history:

Date	Rev	Description	Page
2023.04.04	23.04	Original	